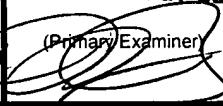


Issue Classification		Application/Control No. 10/711,671	Applicant(s)/Patent under Reexamination CHIU, YAO-CHENG
		Examiner Kim T. Huynh	Art Unit 2112

ISSUE CLASSIFICATION													
ORIGINAL				INTERNATIONAL CLASSIFICATION									
CLASS		SUBCLASS		CLAIMED				NON-CLAIMED					
710		305		G	06	F	13	/14				/	
CROSS REFERENCES												/	
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)											/	
710	306	100	103									/	
												/	
												/	
												/	
												/	
<i>WT</i> Kim T. Huynh 11/15/06 (Assistant Examiner) (Date)				MARK H. RINEHART SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2100				Total Claims Allowed: 10					
 (Legal Instruments Examiner) <i>12/1/06</i> (Date)				 (Primary Examiner) <i>11/06</i> (Date)				O.G. Print Claim(s) 1				O.G. Print Fig. 3	

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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-	5	35	65	95	125	155	185
4	6	36	66	96	126	156	186
5	7	37	67	97	127	157	187
-	8	38	68	98	128	158	188
-	9	39	69	99	129	159	189
-	10	40	70	100	130	160	190
-	11	41	71	101	131	161	191
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8	14	44	74	104	134	164	194
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23		53	83	113	143	173	203
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25		55	85	115	145	175	205
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28		58	88	118	148	178	208
29		59	89	119	149	179	209
30		60	90	120	150	180	210